

TOSHIBA Field Effect Transistor Silicon N Channel MOS Type (π-MOSV)

## 2SK3462

Switching Regulator, DC-DC Converter and Motor Drive Applications

- 4 V Gate drive
- Low drain-source ON resistance:  $R_{DS(ON)} = 1.2 \Omega$  (typ.)
- High forward transfer admittance:  $|Y_{fs}| = 2.2 \text{ S}$  (typ.)
- Low leakage current:  $I_{DSS} = 100 \mu\text{A}$  ( $V_{DS} = 250 \text{ V}$ )
- Enhancement-mode:  $V_{th} = 1.5 \sim 3.5 \text{ V}$  ( $V_{DS} = 10 \text{ V}$ ,  $I_D = 1 \text{ mA}$ )

### Maximum Ratings ( $T_a = 25^\circ\text{C}$ )

| Characteristics                                      |                                       | Symbol    | Rating         | Unit             |
|------------------------------------------------------|---------------------------------------|-----------|----------------|------------------|
| Drain-source voltage                                 |                                       | $V_{DSS}$ | 250            | V                |
| Drain-gate voltage ( $R_{GS} = 20 \text{ k}\Omega$ ) |                                       | $V_{DGR}$ | 250            | V                |
| Gate-source voltage                                  |                                       | $V_{GSS}$ | $\pm 20$       | V                |
| Drain current                                        | DC (Note 1)                           | $I_D$     | 3              | A                |
|                                                      | Pulse ( $t = 1 \text{ ms}$ ) (Note 1) | $I_{DP}$  | 6              |                  |
| Drain power dissipation ( $T_c = 25^\circ\text{C}$ ) |                                       | $P_D$     | 20             | W                |
| Single pulse avalanche energy (Note 2)               |                                       | $E_{AS}$  | 36.2           | mJ               |
| Avalanche current                                    |                                       | $I_{AR}$  | 3              | A                |
| Repetitive avalanche energy (Note 3)                 |                                       | $E_{AR}$  | 2              | mJ               |
| Channel temperature                                  |                                       | $T_{ch}$  | 150            | $^\circ\text{C}$ |
| Storage temperature range                            |                                       | $T_{stg}$ | $-55 \sim 150$ | $^\circ\text{C}$ |

### Thermal Characteristics

| Characteristics                        | Symbol         | Max  | Unit               |
|----------------------------------------|----------------|------|--------------------|
| Thermal resistance, channel to case    | $R_{th(ch-c)}$ | 6.25 | $^\circ\text{C/W}$ |
| Thermal resistance, channel to ambient | $R_{th(ch-a)}$ | 125  | $^\circ\text{C/W}$ |

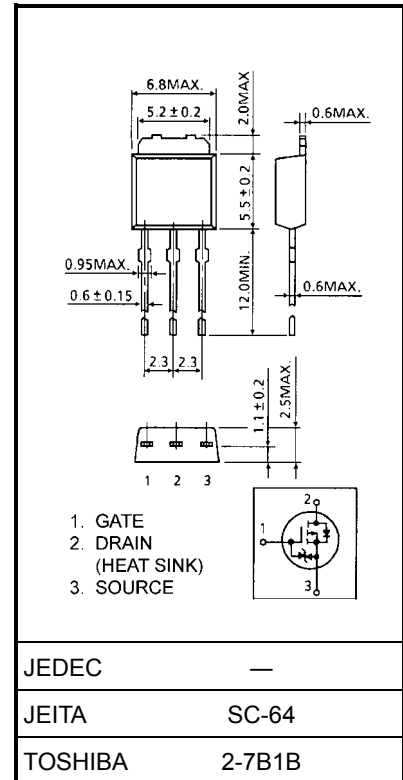
Note 1: Please use devices on conditions that the channel temperature is below  $150^\circ\text{C}$ .

Note 2:  $V_{DD} = 50 \text{ V}$ ,  $T_{ch} = 25^\circ\text{C}$ ,  $L = 6.7 \text{ mH}$ ,  $I_{AR} = 3 \text{ A}$ ,  $R_G = 25 \Omega$

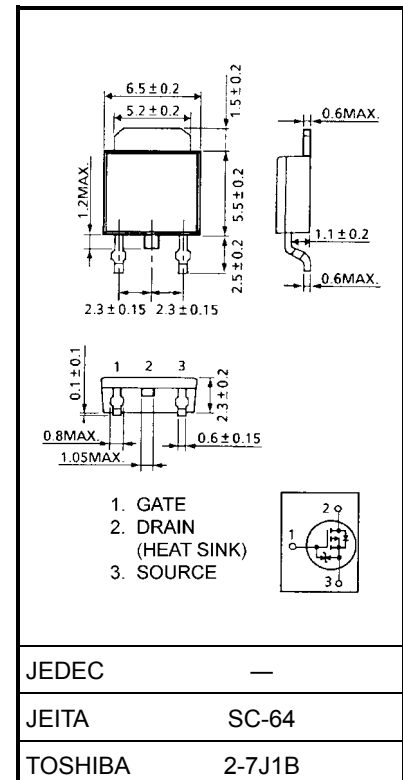
Note 3: Repetitive rating: Pulse width limited by maximum channel temperature

This transistor is an electrostatic sensitive device. Please handle with caution.

Unit: mm

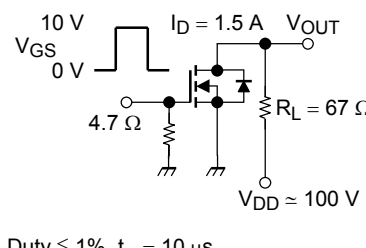


Weight: 0.36 g (typ.)



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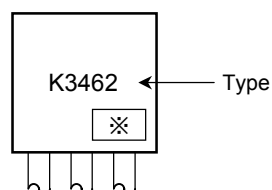
## Electrical Characteristics (Ta = 25°C)

| Characteristics                |               | Symbol        | Test Condition                                                                     | Min | Typ. | Max      | Unit          |
|--------------------------------|---------------|---------------|------------------------------------------------------------------------------------|-----|------|----------|---------------|
| Gate leakage current           |               | $I_{GSS}$     | $V_{GS} = \pm 16 \text{ V}, V_{DS} = 0 \text{ V}$                                  | —   | —    | $\pm 10$ | $\mu\text{A}$ |
| Drain cut-off current          |               | $I_{DSS}$     | $V_{DS} = 250 \text{ V}, V_{GS} = 0 \text{ V}$                                     | —   | —    | 100      | $\mu\text{A}$ |
| Drain-source breakdown voltage |               | $V_{(BR)DSS}$ | $I_D = 10 \text{ mA}, V_{GS} = 0 \text{ V}$                                        | 250 | —    | —        | V             |
| Gate threshold voltage         |               | $V_{th}$      | $V_{DS} = 10 \text{ V}, I_D = 1 \text{ mA}$                                        | 1.5 | —    | 3.5      | V             |
| Drain-source ON resistance     |               | $R_{DS(ON)}$  | $V_{GS} = 10 \text{ V}, I_D = 1.5 \text{ A}$                                       | —   | 1.2  | 1.7      | $\Omega$      |
| Forward transfer admittance    |               | $ Y_{fs} $    | $V_{DS} = 10 \text{ V}, I_D = 1.5 \text{ A}$                                       | 0.5 | 2.2  | —        | S             |
| Input capacitance              |               | $C_{iss}$     | $V_{DS} = 10 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$                   | —   | 267  | —        | pF            |
| Reverse transfer capacitance   |               | $C_{rss}$     |                                                                                    | —   | 32   | —        |               |
| Output capacitance             |               | $C_{oss}$     |                                                                                    | —   | 98   | —        |               |
| Switching time                 | Rise time     | $t_r$         |  | —   | 5    | —        | ns            |
|                                | Turn-on time  | $t_{on}$      |                                                                                    | —   | 20   | —        |               |
|                                | Fall time     | $t_f$         |                                                                                    | —   | 5    | —        |               |
|                                | Turn-off time | $t_{off}$     |                                                                                    | —   | 30   | —        |               |
| Total gate charge              |               | $Q_g$         | $V_{DD} \approx 200 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 3 \text{ A}$           | —   | 12   | —        | nC            |
| Gate-source charge             |               | $Q_{gs}$      |                                                                                    | —   | 6    | —        |               |
| Gate-drain charge              |               | $Q_{gd}$      |                                                                                    | —   | 6    | —        |               |

## Source-Drain Ratings and Characteristics (Ta = 25°C)

| Characteristics                              | Symbol    | Test Condition                                | Min | Typ. | Max  | Unit |
|----------------------------------------------|-----------|-----------------------------------------------|-----|------|------|------|
| Continuous drain reverse current<br>(Note 1) | $I_{DR}$  | —                                             | —   | —    | 3    | A    |
| Pulse drain reverse current<br>(Note 1)      | $I_{DRP}$ | —                                             | —   | —    | 6    | A    |
| Forward voltage (diode)                      | $V_{DSF}$ | $I_{DR} = 3 \text{ A}, V_{GS} = 0 \text{ V}$  | —   | —    | -2.0 | V    |
| Reverse recovery time                        | $t_{rr}$  | $I_{DR} = 3 \text{ A}, V_{GS} = 0 \text{ V},$ | —   | 125  | —    | ns   |
| Reverse recovery charge                      | $Q_{rr}$  | $dI_{DR}/dt = 100 \text{ A}/\mu\text{s}$      | —   | 470  | —    | nC   |

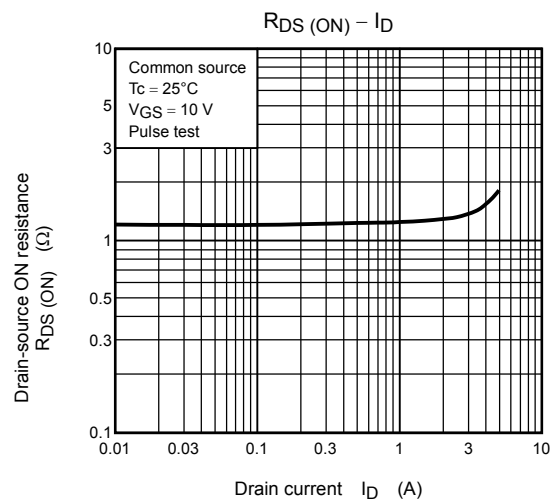
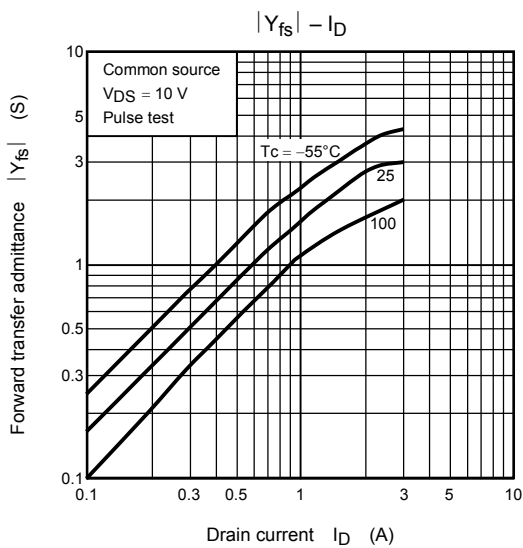
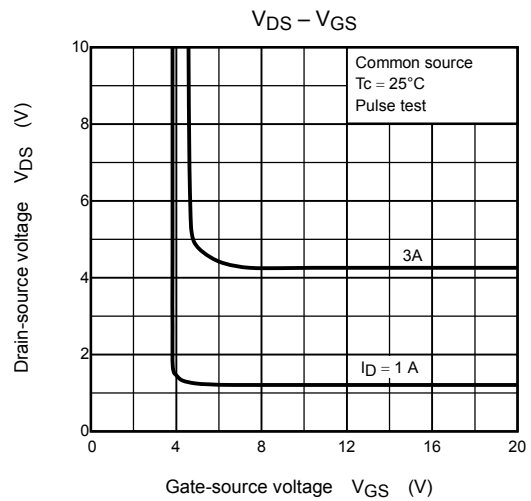
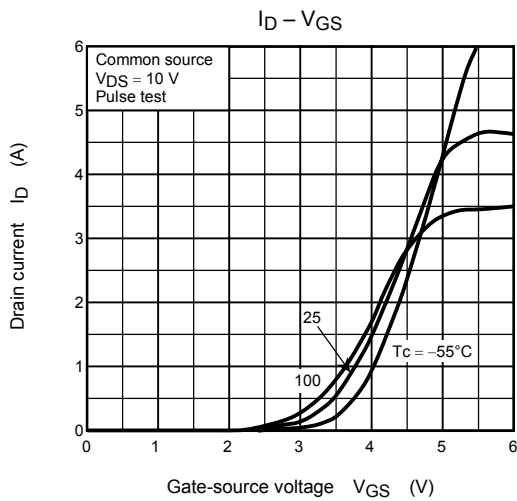
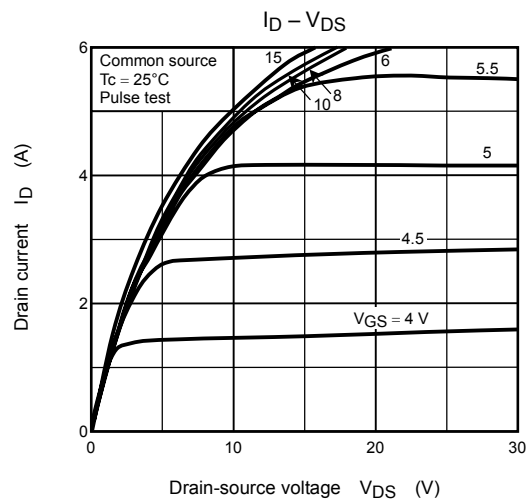
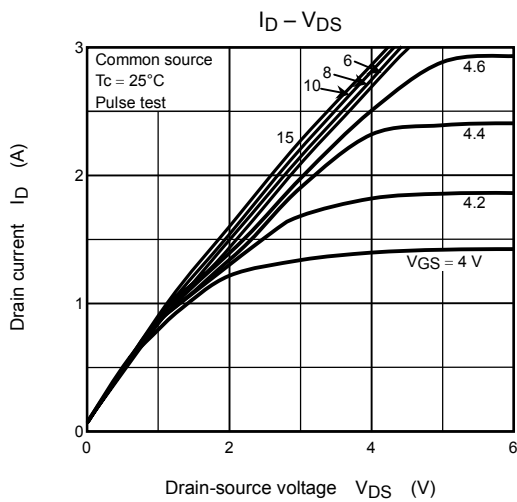
## Marking

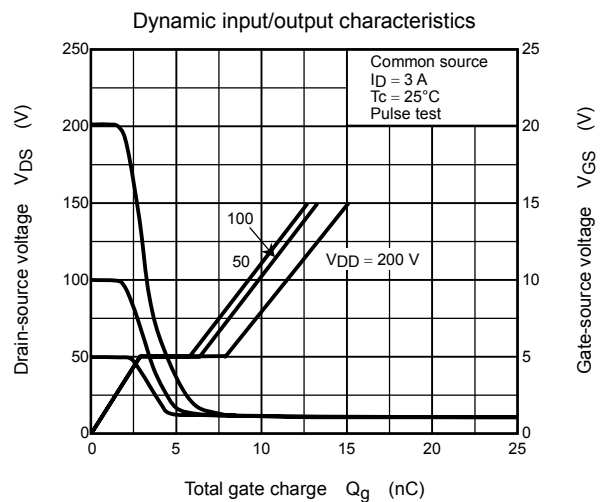
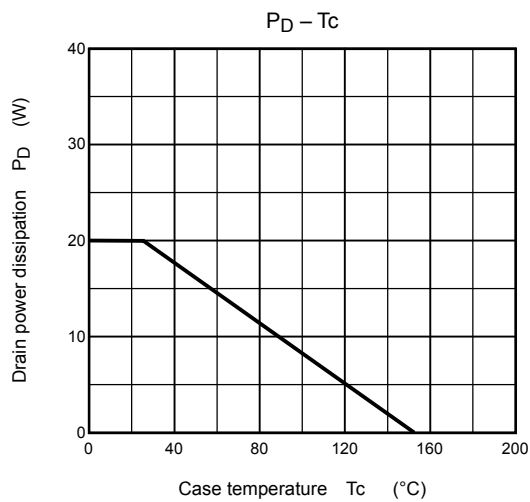
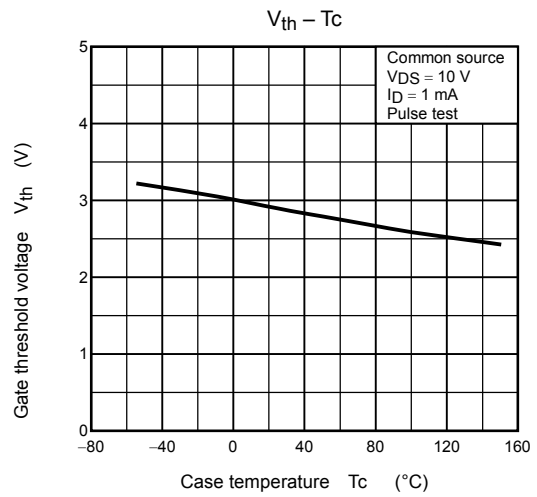
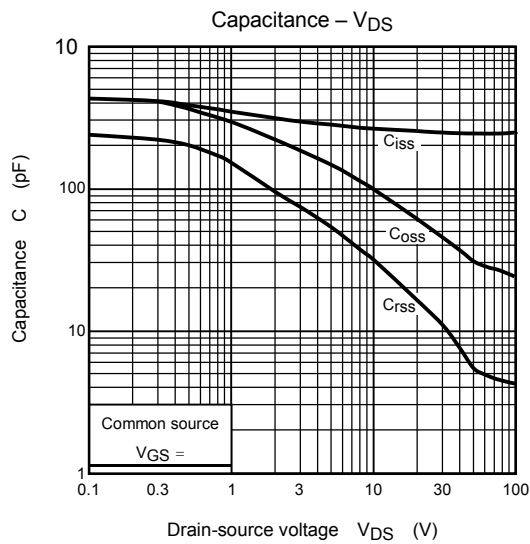
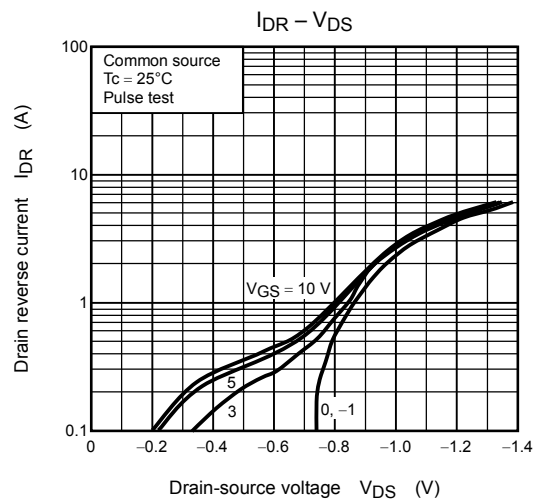
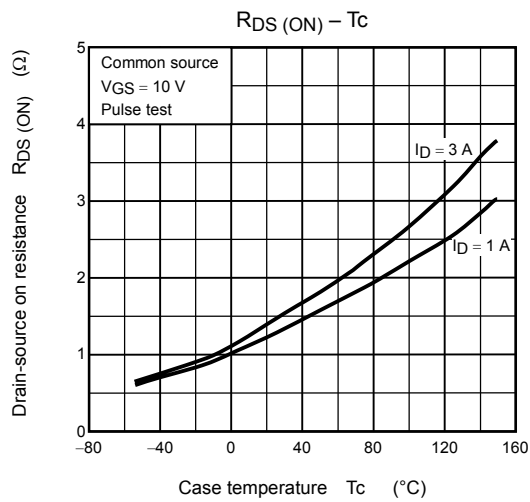


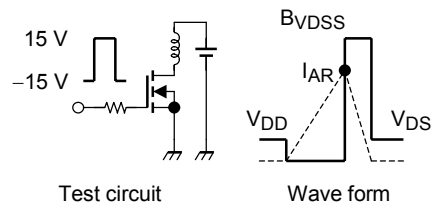
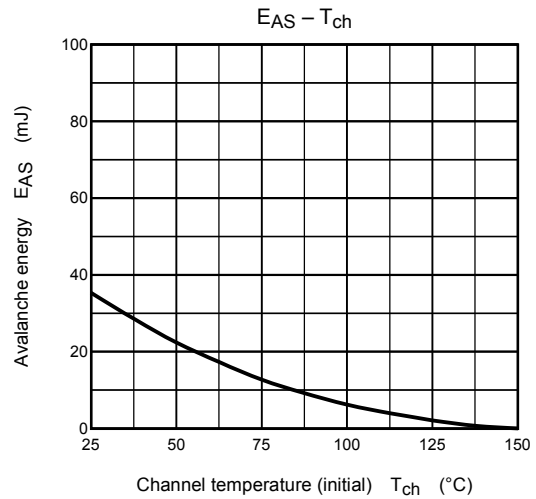
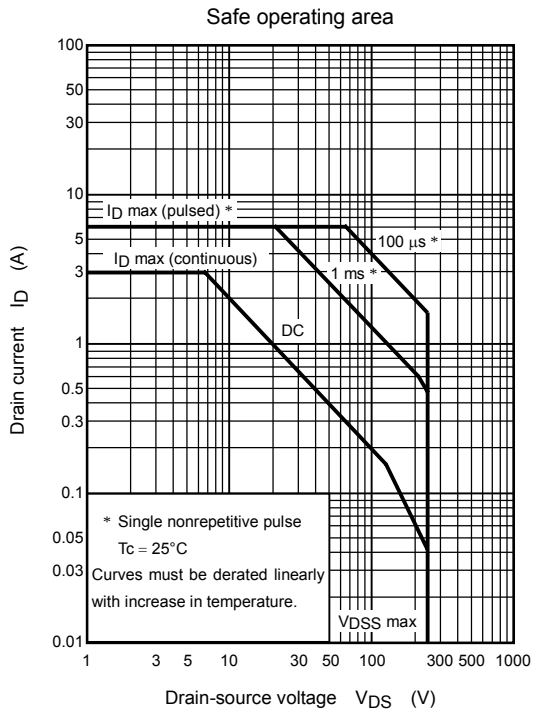
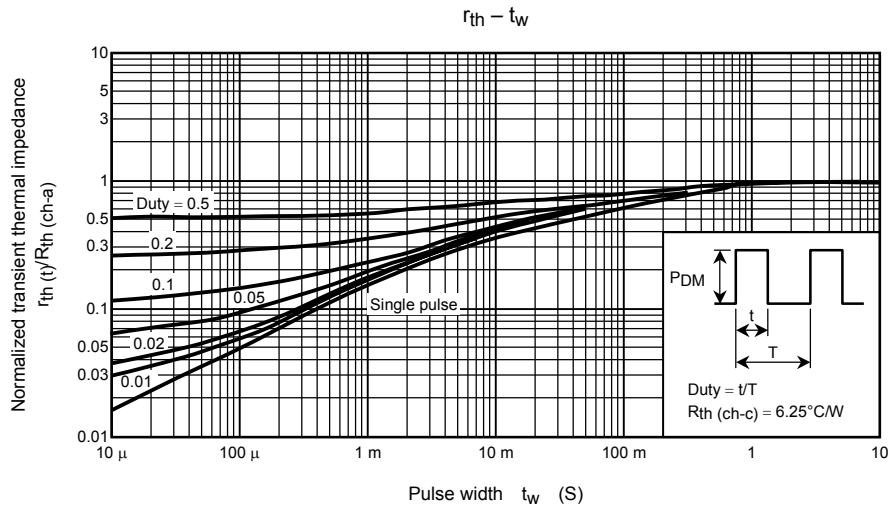
※ Lot Number

Month (starting from alphabet A)

Year (last number of the christian era)







$$R_G = 25 \, \Omega$$

$$V_{DD} = 50 \, \text{V}, L = 6.7 \, \text{mH}$$

$$E_{AS} = \frac{1}{2} \cdot L \cdot I^2 \cdot \left( \frac{B_{VDSS}}{B_{VDSS} - V_{DD}} \right)$$

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